Product data sheet

1. Product profile

1.1 General description

NPN double polysilicon wideband transistor with buried layer for low voltage applications in a plastic, 4-pin dual-emitter SOT343F package.

CAUTION



This device is sensitive to ElectroStatic Discharge (ESD). Therefore care should be taken during transport and handling.

1.2 Features and benefits

- Very high power gain
- Low noise figure
- High transition frequency
- Emitter is thermal lead
- Low feedback capacitance

1.3 Applications

- Radio Frequency (RF) front end wideband applications such as:
 - analog and digital cellular telephones
 - cordless telephones (Cordless Telephone (CT), Personal Handy-phone
 System (PHS), Digital Enhanced Cordless Telecommunications (DECT), etc.)
 - radar detectors
 - pagers
 - Satellite Antenna TeleVison (SATV) tuners
 - high frequency oscillators e.g. Dielectric Resonator Oscillator (DRO) for Low Noise Block (LNB)

1.4 Quick reference data

Table 1. Quick reference data

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
V_{CBO}	collector-base voltage	open emitter	-	-	10	V
V_{CEO}	collector-emitter voltage	open base	-	-	4.5	V
I _C	collector current		-	25	30	mΑ
P _{tot}	total power dissipation	T _{sp} ≤ 90 °C	<u>[1]</u> _	-	135	mW



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Table 1. Quick reference data ...continued

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
h _{FE}	DC current gain	$I_C = 25 \text{ mA}; V_{CE} = 2 \text{ V};$ $T_j = 25 \text{ °C}$	50	80	120	
C_{CBS}	collector-base capacitance	$V_{CB} = 2 \text{ V}; f = 1 \text{ MHz}$	-	102	-	fF
f _T	transition frequency	$I_C = 25 \text{ mA}; V_{CE} = 2 \text{ V};$ f = 2 GHz; $T_{amb} = 25 ^{\circ}\text{C}$	-	25	-	GHz
$G_{p(\text{max})}$	maximum power gain	I_C = 25 mA; V_{CE} = 2 V; f = 2 GHz; T_{amb} = 25 °C	[2] -	23	-	dB
NF	noise figure	I_C = 2 mA; V_{CE} = 2 V; f = 2 GHz; Γ_S = Γ_{opt}	-	1.2	-	dB

^[1] T_{sp} is the temperature at the soldering point of the emitter pins.

2. Pinning information

Table 2. Pinning

	3		
Pin	Description	Simplified outline	Symbol
1	emitter		
2	base	3 4	4
3	emitter		2
4	collector		1, 3
		2 1	mbb159

3. Ordering information

Table 3. Ordering information

Type number	Package				
	Name	Description	Version		
BFG424F	-	plastic surface mounted flat pack package; reverse pinning; 4 leads	SOT343F		

4. Marking

Table 4. Marking

Type number	Marking code ^[1]
BFG424F	NE*

^[1] * = p: made in Hong Kong.

^[2] $G_{p(max)}$ is the maximum power gain, if K > 1. If K < 1 then $G_{p(max)}$ = Maximum Stable Gain (MSG), see Figure 8.

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5. Limiting values

Table 5. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	N	/lin	Max	Unit
V_{CBO}	collector-base voltage	open emitter	-		10	V
V _{CEO}	collector-emitter voltage	open base	-		4.5	V
V_{EBO}	emitter-base voltage	open collector	-		1	V
I _C	collector current		-		30	mA
P _{tot}	total power dissipation	$T_{sp} \le 90 ^{\circ}C$	<u>[1]</u> _		135	mW
T _{stg}	storage temperature		_	65	+150	°C
Tj	junction temperature		-		150	°C

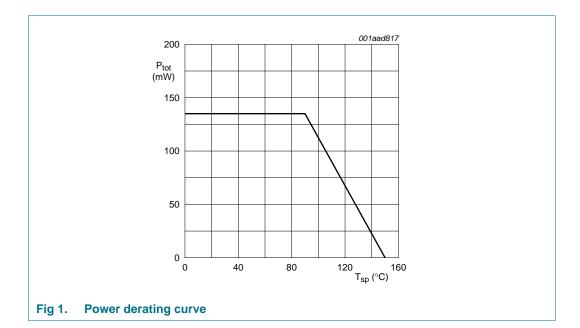
^[1] T_{sp} is the temperature at the soldering point of the emitter pins.

6. Thermal characteristics

Table 6. Thermal characteristics

Symbol	Parameter	Conditions	Тур	Unit
$R_{th(j-sp)}$	thermal resistance from junction to solder point	$T_{sp} \leq 90~^{\circ}C$	[1] 340	K/W

^[1] T_{sp} is the temperature at the soldering point of the emitter pins.



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7. Characteristics

Table 7. Characteristics

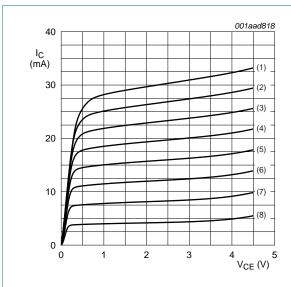
 $T_i = 25$ °C; unless otherwise specified.

Symbol	Parameter	Conditions	N	/lin	Тур	Max	Unit
$V_{(BR)CBO}$	collector-base breakdown voltage	$I_C = 2.5 \mu A; I_E = 0 \text{ mA}$	1	0	-	-	V
$V_{(BR)CEO}$	collector-emitter breakdown voltage	$I_C = 1 \text{ mA}; I_B = 0 \text{ mA}$	4	.5	-	-	V
$V_{(BR)EBO}$	open-collector emitter-base breakdown voltage	$I_E = 2.5 \mu A; I_C = 0 \text{ mA}$	1		-	-	V
I _{CBO}	collector-base cut-off current	$I_E = 0 \text{ mA}; V_{CB} = 4.5 \text{ V}$	-		-	15	nA
h _{FE}	DC current gain	$I_C = 25 \text{ mA}; V_{CE} = 2 \text{ V}$	5	0	80	120	
C _{CES}	collector-emitter capacitance	V _{CB} = 2 V; f = 1 MHz	-		363	-	fF
C _{EBS}	emitter-base capacitance	V _{EB} = 0.5 V; f = 1 MHz	-		475	-	fF
C _{CBS}	collector-base capacitance	$V_{CB} = 2 \text{ V}; f = 1 \text{ MHz}$	-		102	-	fF
f _T	transition frequency	I_C = 25 mA; V_{CE} = 2 V; f = 2 GHz; T_{amb} = 25 °C	-		25	-	GHz
$G_{p(max)} \\$	maximum power gain	I_C = 25 mA; V_{CE} = 2 V; f = 2 GHz; T_{amb} = 25 °C	[1] -		23	-	dB
$ s_{21} ^2$	insertion power gain	I_{C} = 25 mA; V_{CE} = 2 V; f = 2 GHz; T_{amb} = 25 °C	-		18.5	-	dB
NF	noise figure	I_C = 2 mA; V_{CE} = 2 V; f = 900 MHz; Γ_S = Γ_{opt}	-		8.0	-	dB
		I_C = 2 mA; V_{CE} = 2 V; f = 2 GHz; Γ_S = Γ_{opt}	-		1.2	-	dB
P _{L(1dB)}	output power at 1 dB gain compression	$I_C = 25 \text{ mA}; V_{CE} = 2 \text{ V}; f = 2 \text{ GHz};$ $Z_S = Z_{S(opt)}; Z_L = Z_{L(opt)}$	[2] -		12	-	dBm
IP3	third-order intercept point	$I_C = 25 \text{ mA; } V_{CE} = 2 \text{ V; } f = 2 \text{ GHz;}$ $Z_S = Z_{S(opt)}; Z_L = Z_{L(opt)}$	[2] -		22	-	dBm

 $^{[1] \}quad G_{p(max)} \text{ is the maximum power gain, if } K > 1. \text{ If } K < 1 \text{ then } G_{p(max)} = MSG, \text{ see } \underline{Figure \ 8}.$

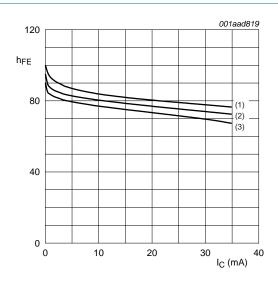
^[2] Z_S is optimized for noise; Z_L is optimized for gain.

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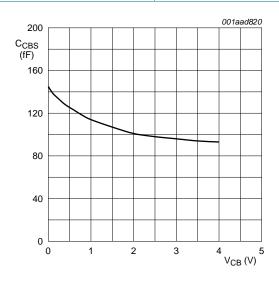
- (1) $I_B = 400 \mu A$
- (2) $I_B = 350 \mu A$
- (3) $I_B = 300 \mu A$
- (4) $I_B = 250 \mu A$
- (5) $I_B = 200 \mu A$
- (6) $I_B = 150 \mu A$
- (7) $I_B = 100 \mu A$
- (8) $I_B = 50 \mu A$

Fig 2. Collector current as a function of collector-emitter voltage; typical values



- (1) $V_{CE} = 3 V$
- (2) $V_{CE} = 2 V$
- (3) $V_{CE} = 1 V$

Fig 3. DC current gain as a function of collector current; typical values



f = 1 MHz

Fig 4. Collector-base capacitance as a function of collector-base voltage; typical values

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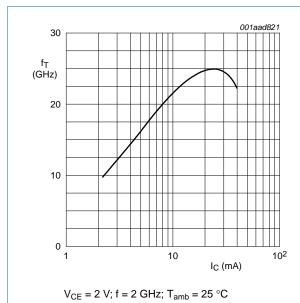
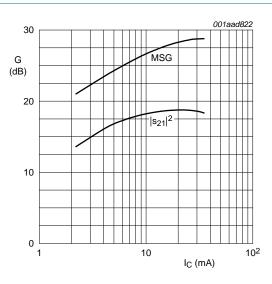
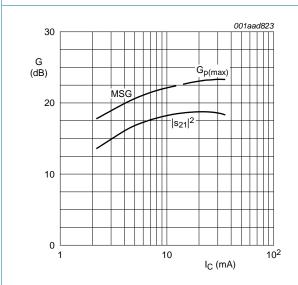


Fig 5. Transition frequency as a function of collector current; typical values



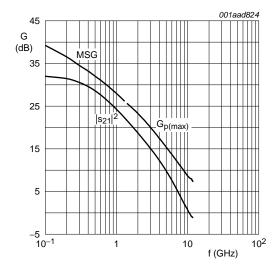
 V_{CE} = 2 V; f = 0.9 GHz; T_{amb} = 25 °C

Fig 6. Gain as a function of collector current; typical values



 V_{CE} = 2 V; f = 2 GHz; T_{amb} = 25 °C





 V_{CE} = 2 V; I_{C} = 25 mA; T_{amb} = 25 °C

Fig 8. Gain as a function of frequency; typical values

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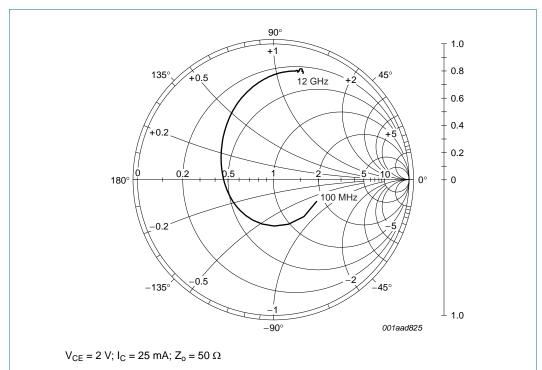


Fig 9. Common emitter input reflection coefficient (s₁₁); typical values

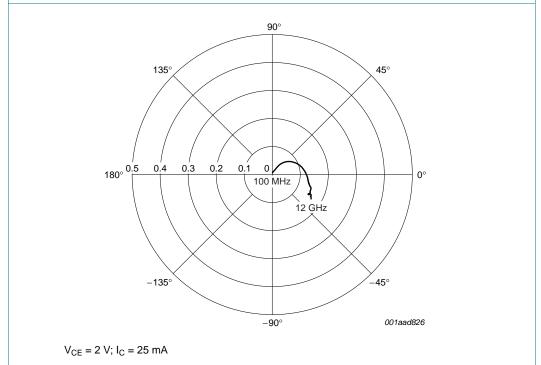


Fig 10. Common emitter reverse transmission coefficient (s₁₂); typical values

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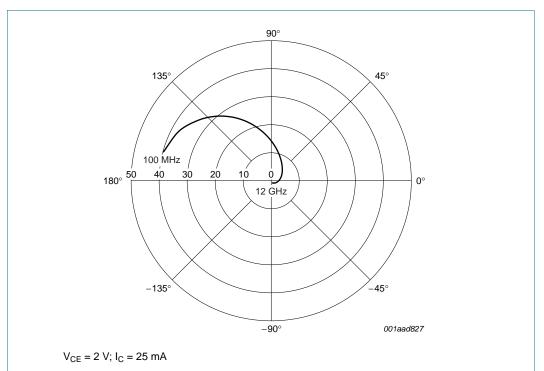
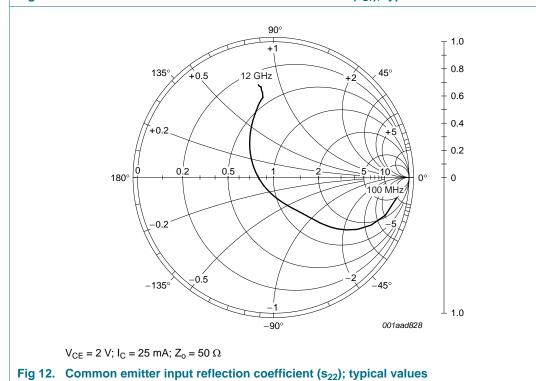


Fig 11. Common emitter forward transmission coefficient (s₂₁); typical values

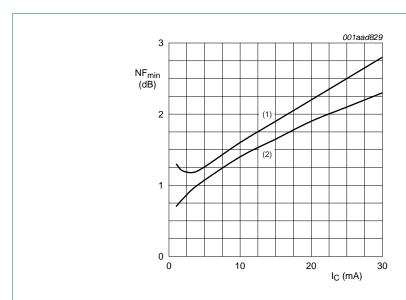


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7.1 Noise data

Table 8. Noise data $V_{CE} = 2 V$; typical values.

f	Ic	NF _{min}	Γ_{opt}		r _n
(MHz)	(mA)	(dB)	ratio	(deg)	(Ω)
900	1	0.7	0.67	19.1	0.40
	2	0.81	0.48	17.8	0.27
	4	1	0.28	11.7	0.24
	10	1.4	0.02	-63.9	0.19
	15	1.65	0.11	-162.4	0.18
	20	1.9	0.19	-165.5	0.18
	25	2.1	0.25	-166.3	0.19
	30	2.3	0.29	-166.5	0.19
2000	1	1.3	0.56	57.5	0.36
	2	1.2	0.43	57.2	0.25
	4	1.2	0.22	60.8	0.18
	10	1.6	0.06	137.4	0.19
	15	1.9	0.13	-162.1	0.20
	20	2.2	0.17	-155.5	0.20
	25	2.5	0.22	-152.2	0.21
	30	2.8	0.27	-150.8	0.25



- (1) f = 2 GHz
- (2) f = 900 MHz

Fig 13. Minimum noise figure as a function of collector current; typical values

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8. Package outline

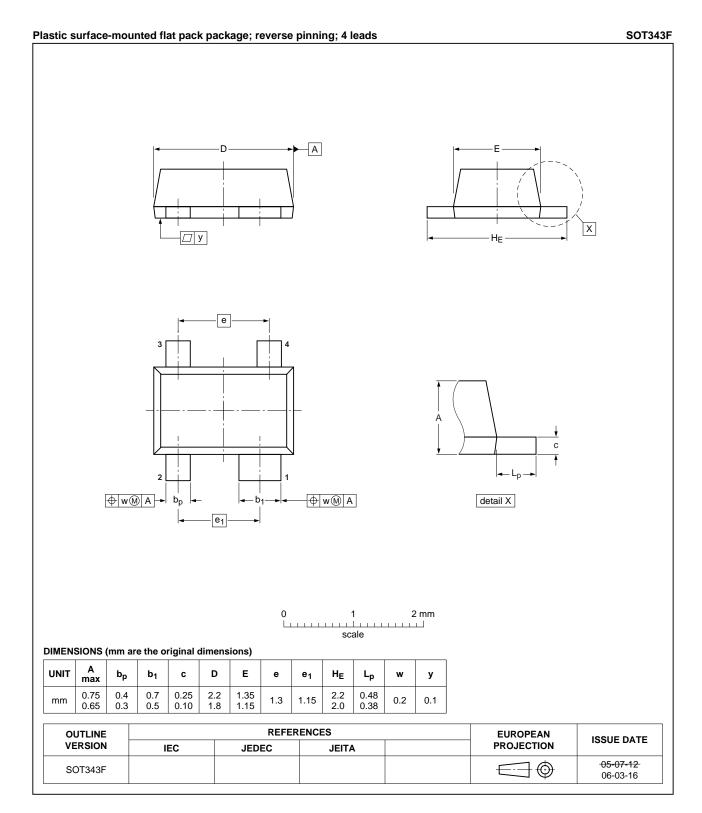


Fig 14. Package outline SOT343F

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9. Revision history

Table 9. Revision history

Document ID	Release date	Data sheet status	Change notice	Supersedes
BFG424F v.2	20110913	Product data sheet	-	BFG424F v.1
Modifications:	 The format of this data sheet has been redesigned to comply with the new identity guidelines of NXP Semiconductors. 			vith the new identity
	 Legal texts 	have been adapted to the	new company name whe	ere appropriate.
BFG424F v.1	20060321	Product data sheet	-	-

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10. Legal information

10.1 Data sheet status

Document status[1][2]	Product status[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

- [1] Please consult the most recently issued document before initiating or completing a design.
- [2] The term 'short data sheet' is explained in section "Definitions"
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BFG424F

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BFG424F **NXP Semiconductors**

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